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| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination HUMMEL ET AL. | |
| | | Examiner Justin Stefanon | Art Unit 3682 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|-----------------|----------------|
| | A | US-5989140 | 11-1999 | Ichikawa et al. | 474/148 |
| | B | US-270723 | 01-1883 | Aydelott | 474/212 |
| | C | US-6039665 | 03-2000 | Nakamura | 474/157 |
| | D | US-4741725 | 05-1988 | Ingold | 474/212 |
| | E | US-5362278 | 11-1994 | Bergles et al. | 474/69 |
| | F | US- | | | |
| | G | US- | | | |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
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